

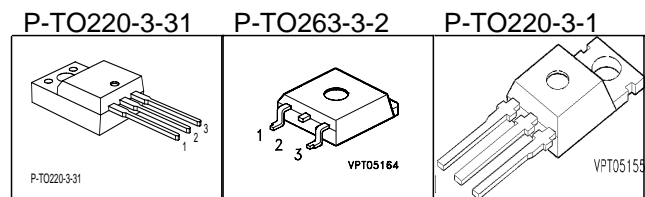
Cool MOS™ Power Transistor

Feature

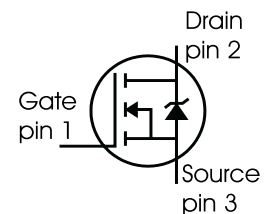
- New revolutionary high voltage technology
- Worldwide best $R_{DS(on)}$ in TO 220
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- High peak current capability
- Improved transconductance
- 150 °C operating temperature

Product Summary

| | | |
|---------------------|------|----------|
| $V_{DS} @ T_{jmax}$ | 650 | V |
| $R_{DS(on)}$ | 0.19 | Ω |
| I_D | 20.7 | A |



| Type | Package | Ordering Code | Marking |
|------------|--------------|---------------|---------|
| SPP20N60C3 | P-TO220-3-1 | Q67040-S4398 | 20N60C3 |
| SPB20N60C3 | P-TO263-3-2 | Q67040-S4397 | 20N60C3 |
| SPA20N60C3 | P-TO220-3-31 | Q67040-S4410 | 20N60C3 |



Maximum Ratings

| Parameter | Symbol | Value | | Unit |
|---|---------------------|--------------|--|------|
| | | SPP_B | SPA | |
| Continuous drain current $T_C = 25\text{ °C}$ $T_C = 100\text{ °C}$ | I_D | 20.7 13.1 | 20.7 ¹⁾ 13.1 ¹⁾ | A |
| Pulsed drain current, t_p limited by T_{jmax} | $I_{D\text{ puls}}$ | 62.1 | 62.1 | A |
| Avalanche energy, single pulse $I_D=10\text{A}$, $V_{DD}=50\text{V}$ | E_{AS} | 690 | 690 | mJ |
| Avalanche energy, repetitive t_{AR} limited by T_{jmax} ²⁾ $I_D=20\text{A}$, $V_{DD}=50\text{V}$ | E_{AR} | 1 | 1 | |
| Avalanche current, repetitive t_{AR} limited by T_{jmax} | I_{AR} | 20 | 20 | A |
| Reverse diode dv/dt $I_S = 20.7\text{ A}$, $V_{DS} < V_{DD}$, $di/dt=100\text{A}/\mu\text{s}$, $T_{jmax}=150\text{ °C}$ | dv/dt | 6 | 6 | V/ns |
| Gate source voltage static | V_{GS} | ± 20 | ± 20 | V |
| Gate source voltage AC ($f > 1\text{Hz}$) | V_{GS} | ± 30 | ± 30 | |
| Power dissipation, $T_C = 25\text{ °C}$ | P_{tot} | 208 | 34.5 | W |
| Operating and storage temperature | T_j, T_{stg} | -55...+150 | | °C |

Thermal Characteristics

| Parameter | Symbol | Values | | | Unit |
|---|----------------|--------|------|------|------|
| | | min. | typ. | max. | |
| Characteristics | | | | | |
| Thermal resistance, junction - case | R_{thJC} | - | - | 0.6 | K/W |
| Thermal resistance, junction - case, FullPAK | R_{thJC_FP} | - | - | 3.6 | |
| Thermal resistance, junction - ambient, leaded | R_{thJA} | - | - | 62 | |
| Thermal resistance, junction - ambient, FullPAK | R_{thJA_FP} | - | - | 80 | |
| SMD version, device on PCB: @ min. footprint @ 6 cm ² cooling area ³⁾ | R_{thJA} | - | - | 62 | |
| | | - | 35 | - | |
| Linear derating factor | | - | - | 1.67 | W/K |
| Linear derating factor, FullPAK | | - | - | 0.28 | |
| Soldering temperature, 1.6 mm (0.063 in.) from case for 10s | T_{sold} | - | - | 260 | °C |

Electrical Characteristics, at $T_j = 25\text{ °C}$, unless otherwise specified

Static Characteristics

| | | | | | |
|--|---------------|-----|------|------|----|
| Drain-source breakdown voltage $V_{GS}=0V, I_D=0.25mA$ | $V_{(BR)DSS}$ | 600 | - | - | V |
| Drain-source avalanche breakdown voltage $V_{GS}=0V, I_D=20A$ | $V_{(BR)DS}$ | - | 700 | - | |
| Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 1\text{ mA}$ | $V_{GS(th)}$ | 2.1 | 3 | 3.9 | |
| Zero gate voltage drain current $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}, T_j = 25\text{ °C}$ $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}, T_j = 150\text{ °C}$ | I_{DSS} | - | 0.1 | 1 | μA |
| | | - | - | 100 | |
| Gate-source leakage current $V_{GS}=30V, V_{DS}=0V$ | I_{GSS} | - | - | 100 | nA |
| Drain-source on-state resistance $V_{GS}=10V, I_D=13.1A, T_j=25\text{ °C}$ $V_{GS}=10V, I_D=13.1A, T_j=150\text{ °C}$ | $R_{DS(on)}$ | - | 0.16 | 0.19 | Ω |
| | | - | 0.54 | 0.64 | |
| Gate input resistance $f = 1\text{ MHz}, \text{ open drain}$ | R_G | - | 0.54 | - | |

Electrical Characteristics

| Parameter | Symbol | Conditions | Values | | | Unit |
|---|-----------------|--|--------|------|------|------|
| | | | min. | typ. | max. | |
| Characteristics | | | | | | |
| Transconductance | g_{fs} | $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$, $I_D = 13.1A$ | - | 17.5 | - | S |
| Input capacitance | C_{iss} | $V_{GS} = 0V$, $V_{DS} = 25V$, | - | 2400 | - | pF |
| Output capacitance | C_{oss} | $f = 1MHz$ | - | 780 | - | |
| Reverse transfer capacitance | C_{rss} | | - | 50 | - | |
| Effective output capacitance, ⁴⁾ energy related | $C_{o(er)}$ | $V_{GS} = 0V$, $V_{DS} = 0V$ to 480V | - | 83 | - | |
| Effective output capacitance, ⁵⁾ time related | $C_{o(tr)}$ | | - | 160 | - | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD} = 380V$, $V_{GS} = 0/13V$, $I_D = 20.7A$, $R_G = 3.6\Omega$, $T_J = 125$ | - | 10 | - | ns |
| Rise time | t_r | $V_{DD} = 380V$, $V_{GS} = 0/13V$, | - | 5 | - | |
| Turn-off delay time | $t_{d(off)}$ | $I_D = 20.7A$, | - | 67 | 100 | |
| Fall time | t_f | $R_G = 3.6\Omega$ | - | 4.5 | 12 | |
| Gate Charge Characteristics | | | | | | |
| Gate to source charge | Q_{gs} | $V_{DD} = 480V$, $I_D = 20.7A$ | - | 11 | - | nC |
| Gate to drain charge | Q_{gd} | | - | 33 | - | |
| Gate charge total | Q_g | $V_{DD} = 480V$, $I_D = 20.7A$, $V_{GS} = 0$ to 10V | - | 87 | 114 | |
| Gate plateau voltage | $V_{(plateau)}$ | $V_{DD} = 480V$, $I_D = 20.7A$ | - | 5.5 | - | V |

¹Limited only by maximum temperature

²Repetitive avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR} \cdot f$.

³Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical without blown air.

⁴ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

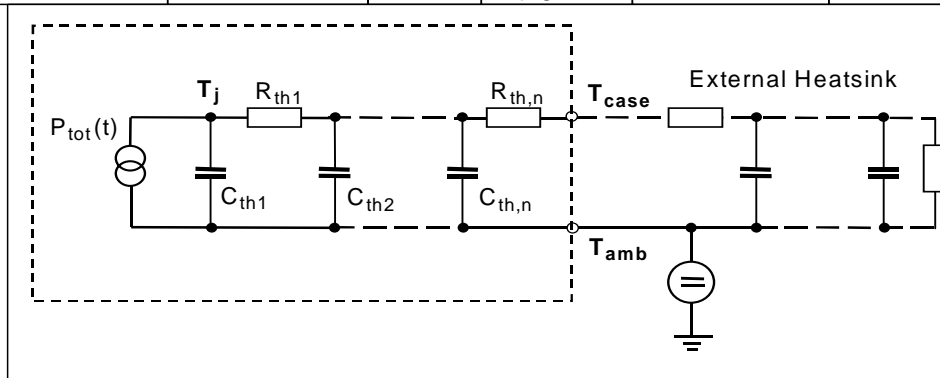
⁵ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

Electrical Characteristics

| Parameter | Symbol | Conditions | Values | | | Unit |
|---|--------------|-----------------------------------|--------|------|------|------------------------|
| | | | min. | typ. | max. | |
| Characteristics | | | | | | |
| Inverse diode continuous forward current | I_S | $T_C=25^\circ\text{C}$ | - | - | 20.7 | A |
| Inverse diode direct current, pulsed | I_{SM} | | - | - | 62.1 | |
| Inverse diode forward voltage | V_{SD} | $V_{GS}=0\text{V}, I_F=I_S$ | - | 1 | 1.2 | V |
| Reverse recovery time | t_{rr} | $V_R=480\text{V}, I_F=I_S,$ | - | 500 | 800 | ns |
| Reverse recovery charge | Q_{rr} | $di_F/dt=100\text{A}/\mu\text{s}$ | - | 11 | - | μC |
| Peak reverse recovery current | I_{rrm} | | - | 70 | - | A |
| Peak rate of fall of reverse recovery current | di_{rr}/dt | $T_j=25^\circ\text{C}$ | - | 1400 | - | $\text{A}/\mu\text{s}$ |

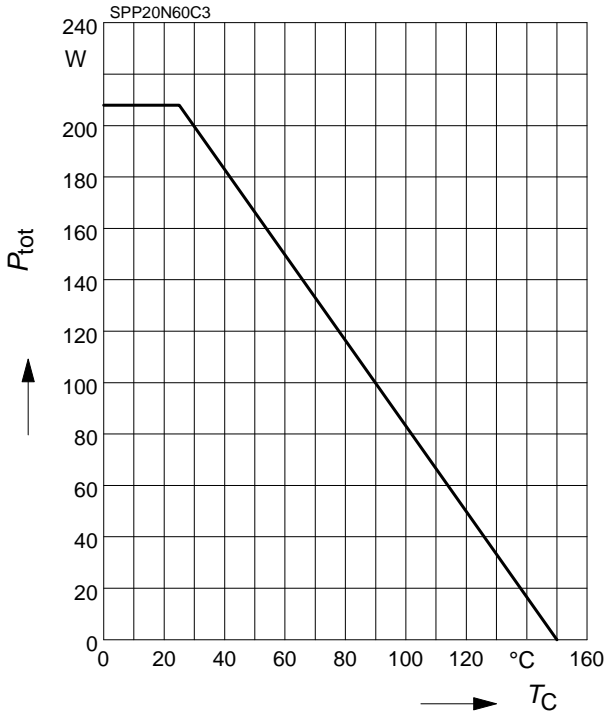
Typical Transient Thermal Characteristics

| Symbol | Value | | Unit | Symbol | Value | | Unit |
|-----------|---------|--------|------|-----------|----------|----------|------|
| | SPP_B | SPA | | | SPP_B | SPA | |
| R_{th1} | 0.00746 | 0.0077 | K/W | C_{th1} | 0.000439 | 0.000376 | Ws/K |
| R_{th2} | 0.017 | 0.015 | | C_{th2} | 0.00145 | 0.00141 | |
| R_{th3} | 0.028 | 0.022 | | C_{th3} | 0.00239 | 0.00192 | |
| R_{th4} | 0.065 | 0.063 | | C_{th4} | 0.00499 | 0.00323 | |
| R_{th5} | 0.081 | 0.214 | | C_{th5} | 0.021 | 0.019 | |
| R_{th6} | 0.037 | 2.479 | | C_{th6} | 0.146 | 0.412 | |



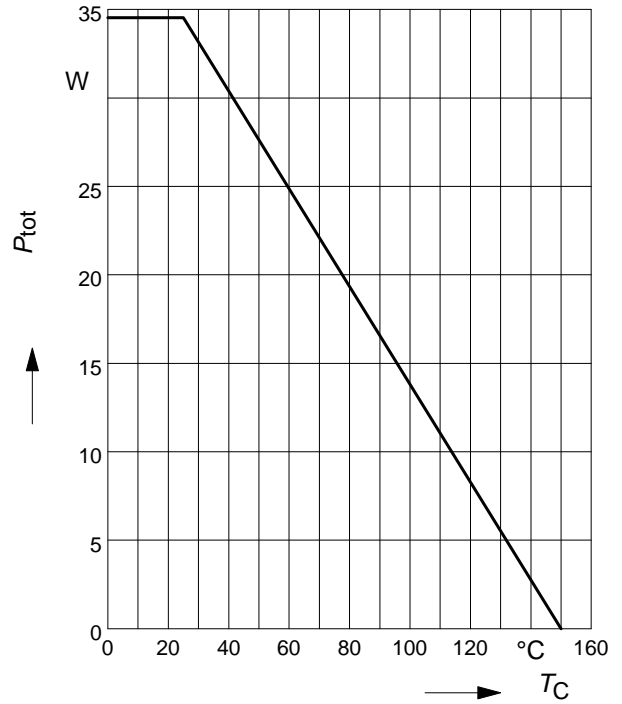
1 Power dissipation

$$P_{tot} = f(T_C)$$



2 Power dissipation FullPAK

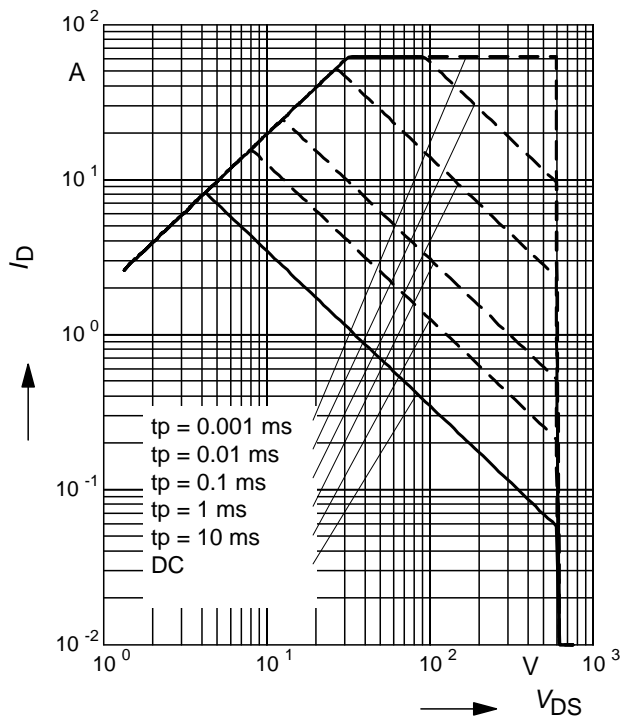
$$P_{tot} = f(T_C)$$



3 Safe operating area FullPAK

$$I_D = f(V_{DS})$$

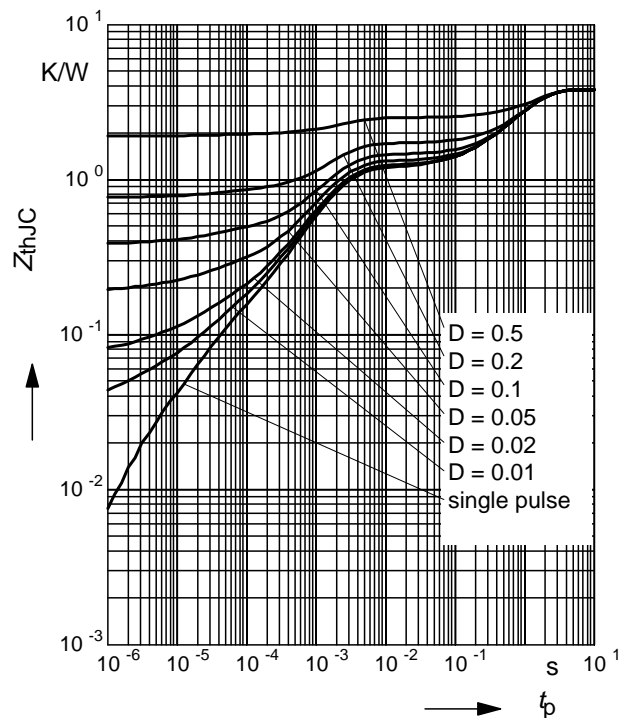
parameter: $D = 0$, $T_C = 25^\circ\text{C}$



4 Transient thermal impedance FullPAK

$$Z_{thJC} = f(t_p)$$

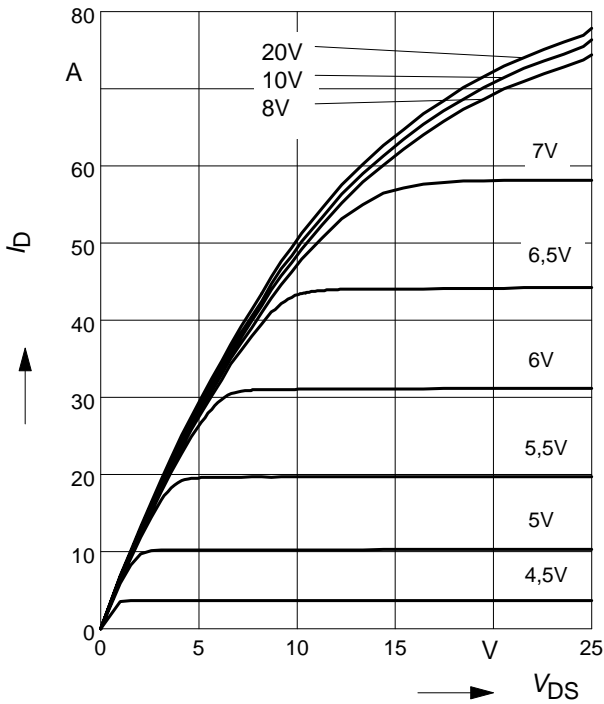
parameter: $D = t_p/t$



5 Typ. output characteristic

$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$

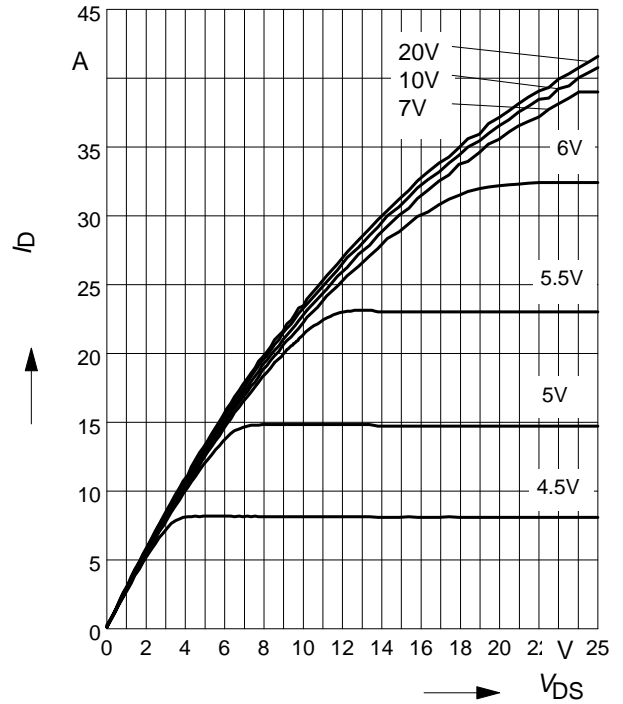
parameter: $t_p = 10 \mu\text{s}, V_{GS}$



6 Typ. output characteristic

$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$

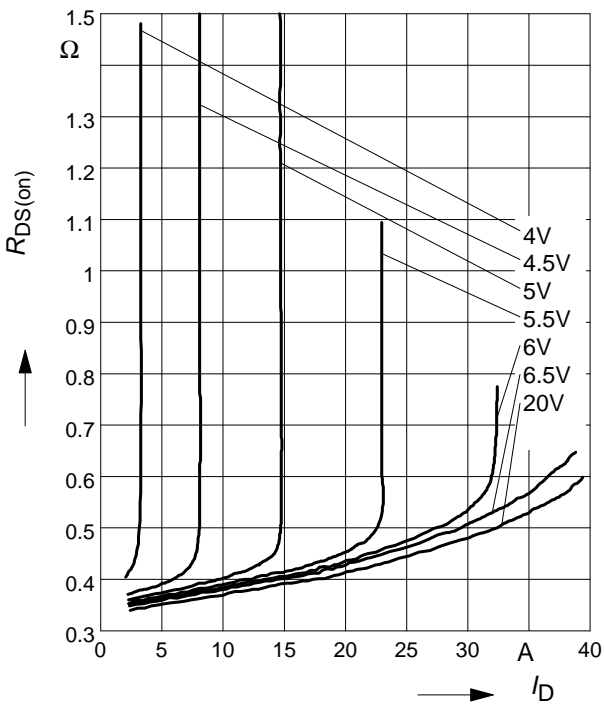
parameter: $t_p = 10 \mu\text{s}, V_{GS}$



7 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$

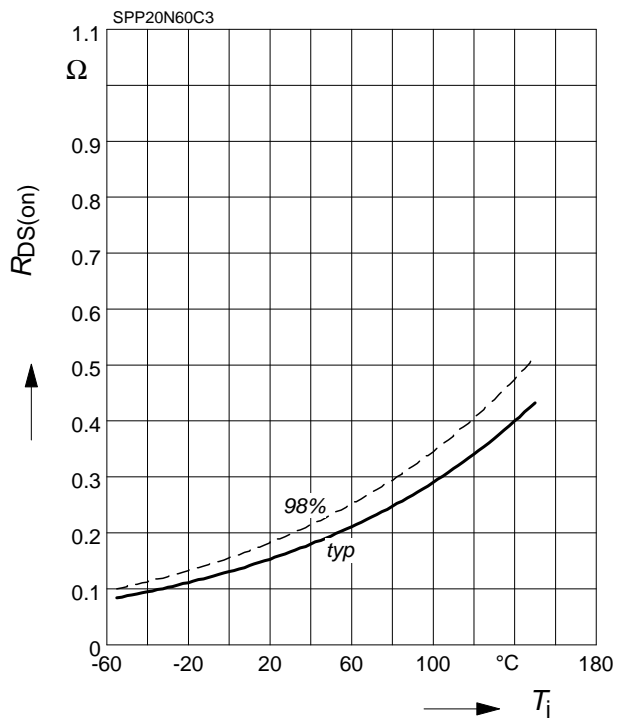
parameter: $T_j = 150^\circ\text{C}, V_{GS}$



8 Drain-source on-state resistance

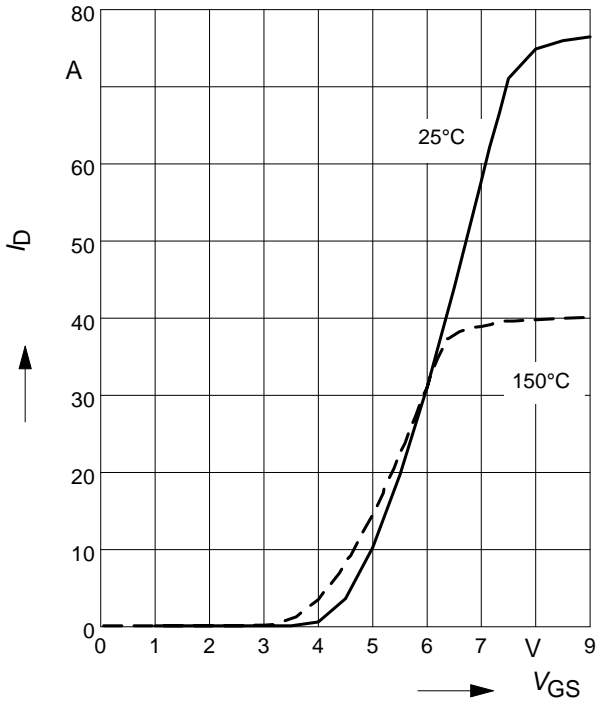
$R_{DS(on)} = f(T_j)$

parameter: $I_D = 13.1 \text{ A}, V_{GS} = 10 \text{ V}$



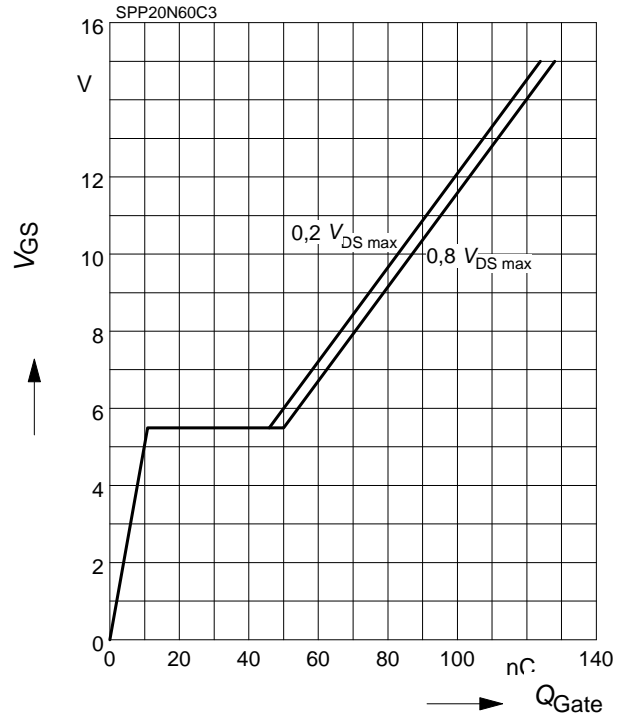
9 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$
parameter: $t_p = 10 \mu s$



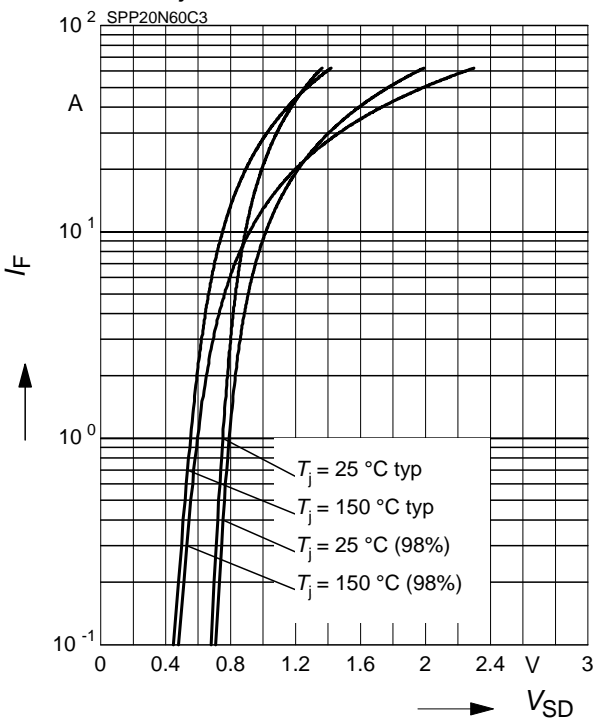
10 Typ. gate charge

$V_{GS} = f(Q_{Gate})$
parameter: $I_D = 20.7 A$ pulsed



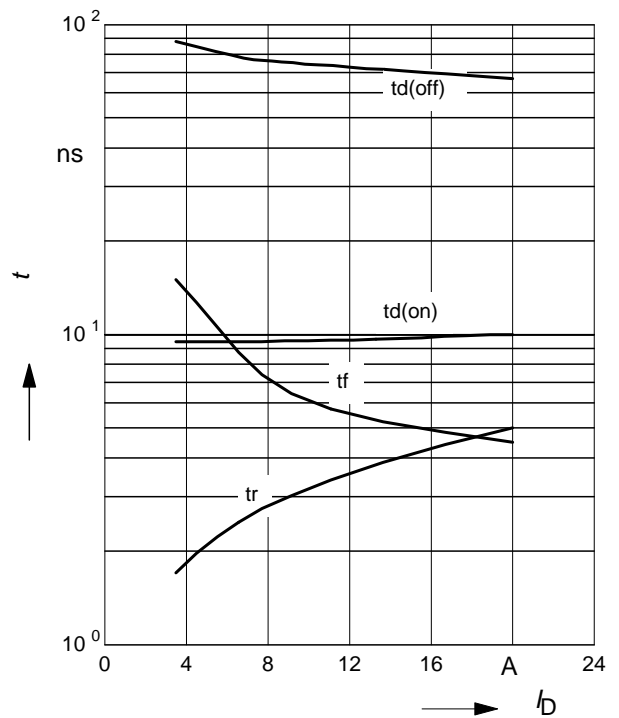
11 Forward characteristics of body diode

$I_F = f(V_{SD})$
parameter: T_j , $t_p = 10 \mu s$



12 Typ. switching time

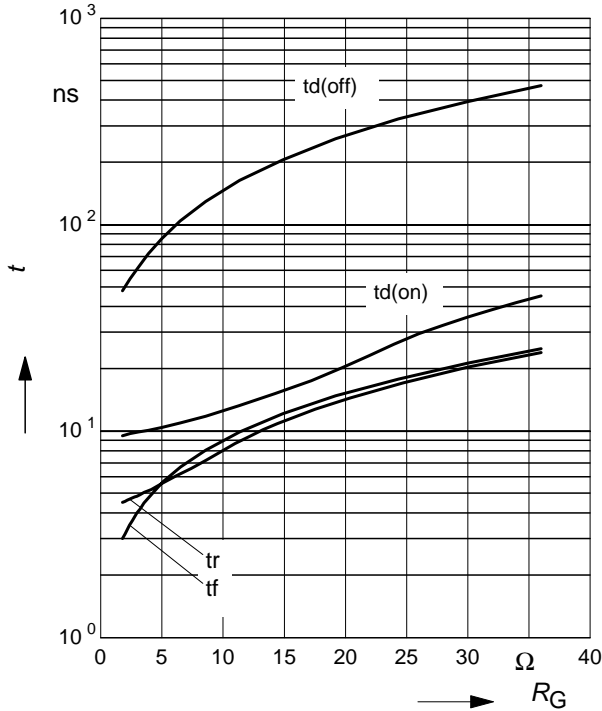
$t = f(I_D)$, inductive load, $T_j = 125^\circ C$
par.: $V_{DS} = 380V$, $V_{GS} = 0/+13V$, $R_G = 3.6\Omega$



13 Typ. switching time

$t = f(R_G)$, inductive load, $T_j = 125^\circ\text{C}$

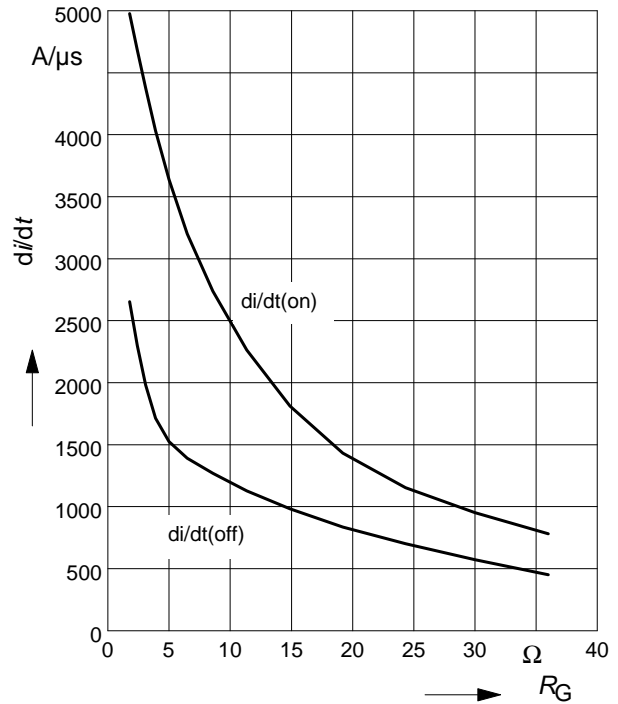
par.: $V_{DS} = 380\text{V}$, $V_{GS} = 0/+13\text{V}$, $I_D = 20.7\text{A}$



14 Typ. drain current slope

$di/dt = f(R_G)$, inductive load, $T_j = 125^\circ\text{C}$

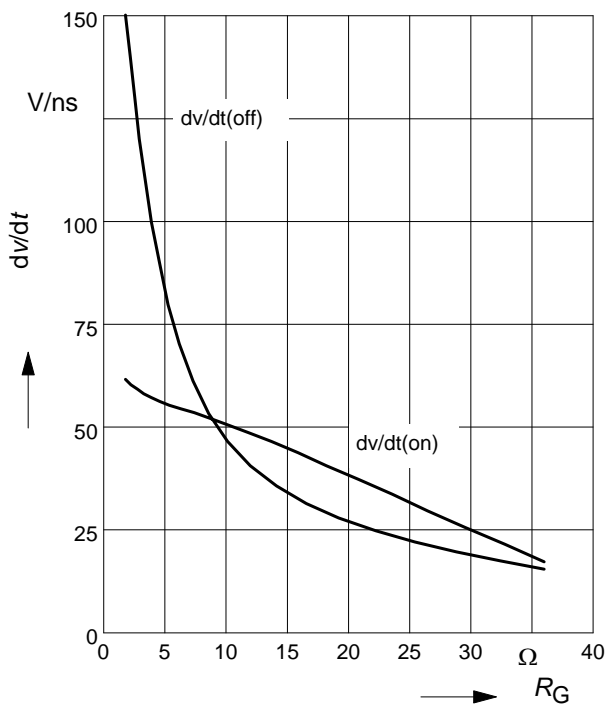
par.: $V_{DS} = 380\text{V}$, $V_{GS} = 0/+13\text{V}$, $I_D = 20.7\text{A}$



15 Typ. drain source voltage slope

$dv/dt = f(R_G)$, inductive load, $T_j = 125^\circ\text{C}$

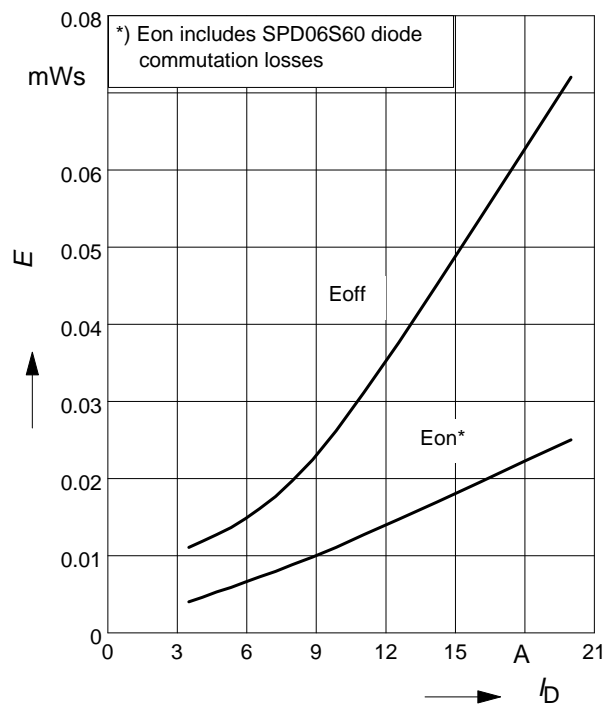
par.: $V_{DS} = 380\text{V}$, $V_{GS} = 0/+13\text{V}$, $I_D = 20.7\text{A}$



16 Typ. switching losses

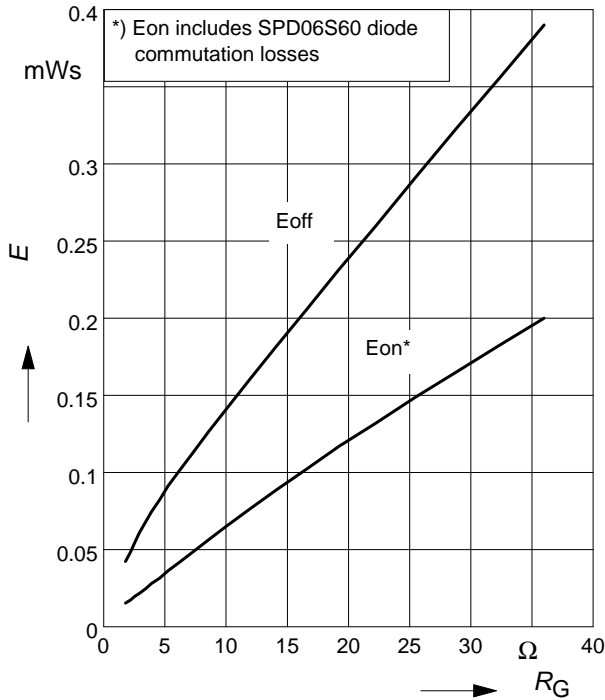
$E = f(I_D)$, inductive load, $T_j = 125^\circ\text{C}$

par.: $V_{DS} = 380\text{V}$, $V_{GS} = 0/+13\text{V}$, $R_G = 3.6\Omega$



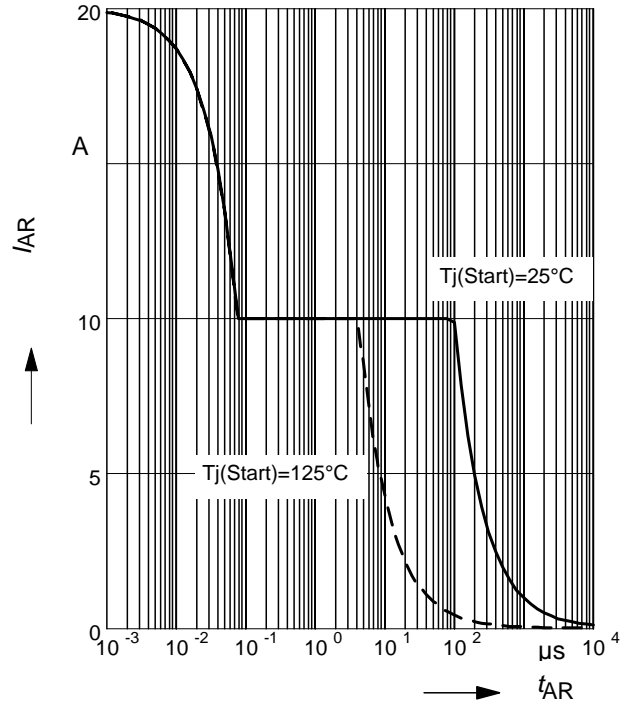
17 Typ. switching losses

$E = f(R_G)$, inductive load, $T_j = 125^\circ\text{C}$
par.: $V_{DS} = 380\text{V}$, $V_{GS} = 0/+13\text{V}$, $I_D = 20.7\text{A}$



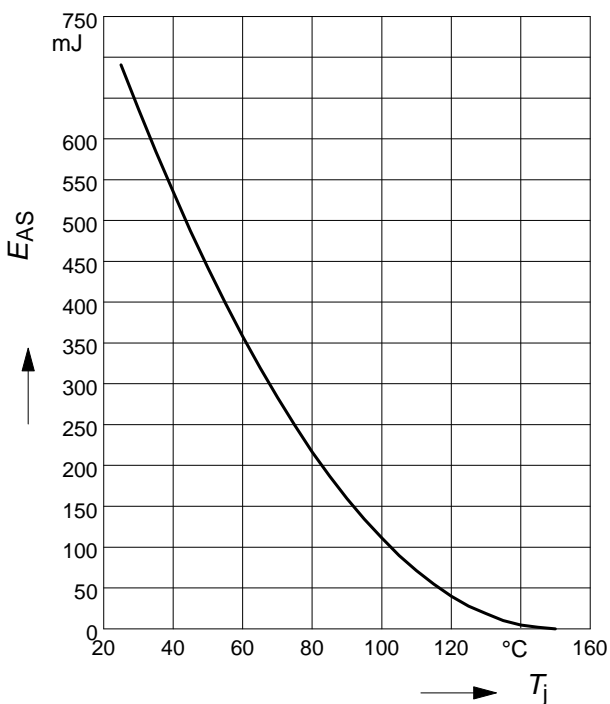
18 Avalanche SOA

$I_{AR} = f(t_{AR})$
par.: $T_j \leq 150^\circ\text{C}$



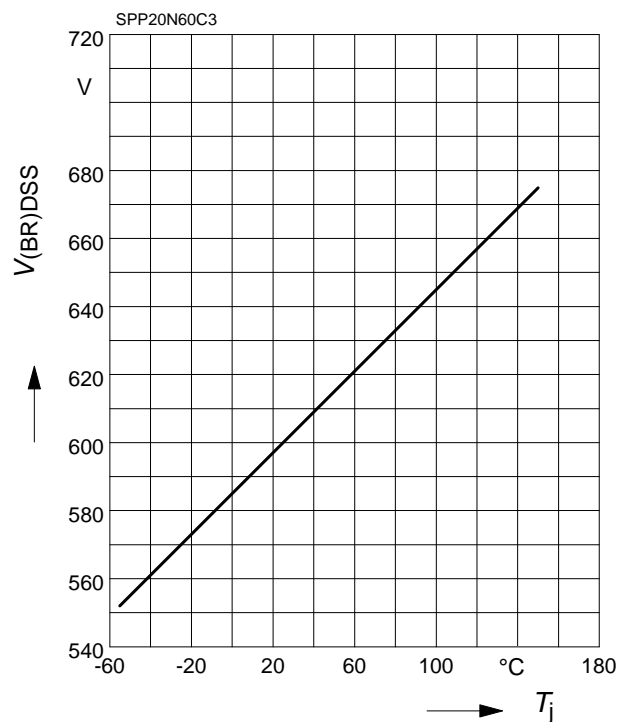
19 Avalanche energy

$E_{AS} = f(T_j)$
par.: $I_D = 10\text{A}$, $V_{DD} = 50\text{V}$



20 Drain-source breakdown voltage

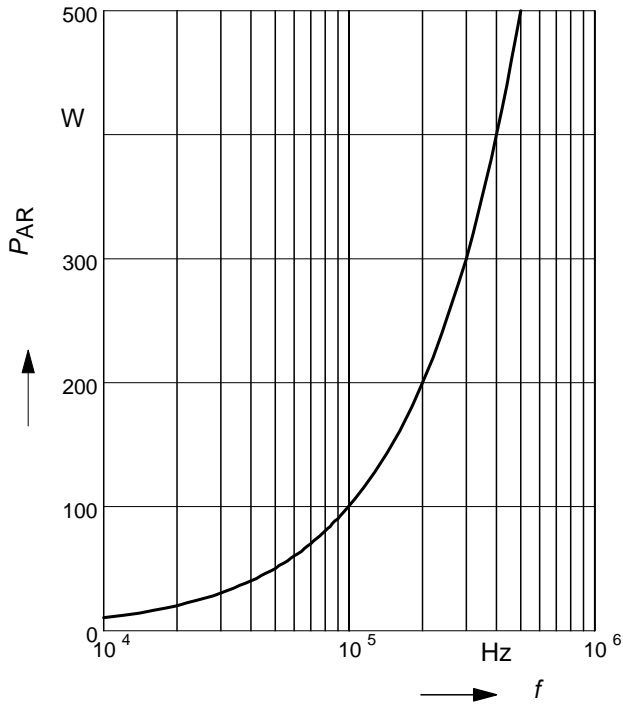
$V_{(BR)DSS} = f(T_j)$



21 Avalanche power losses

$$P_{AR} = f(f)$$

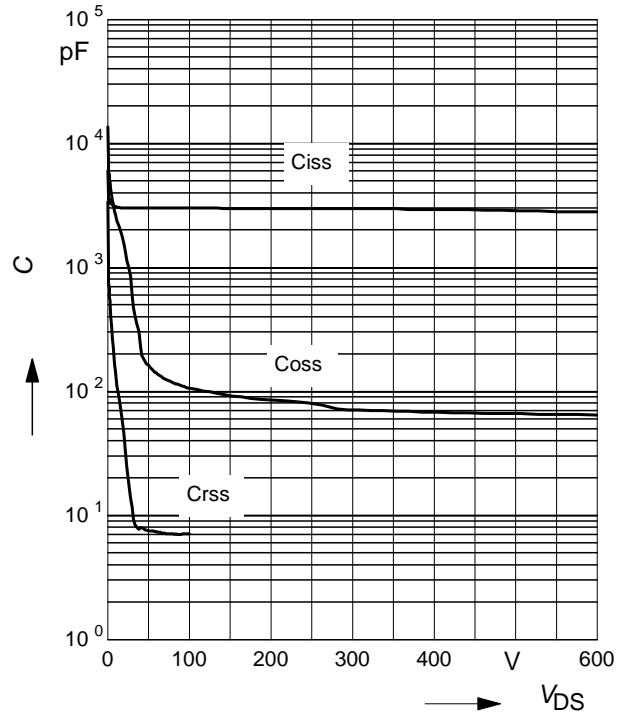
parameter: $E_{AR}=1\text{mJ}$



22 Typ. capacitances

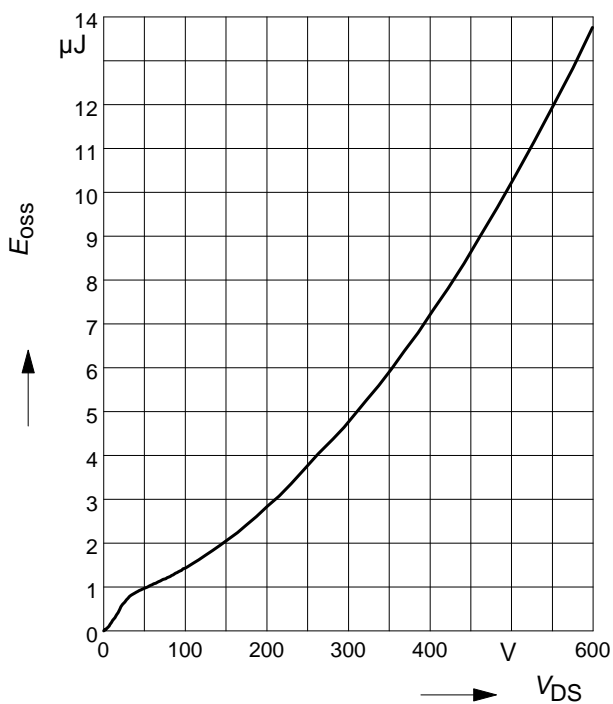
$$C = f(V_{DS})$$

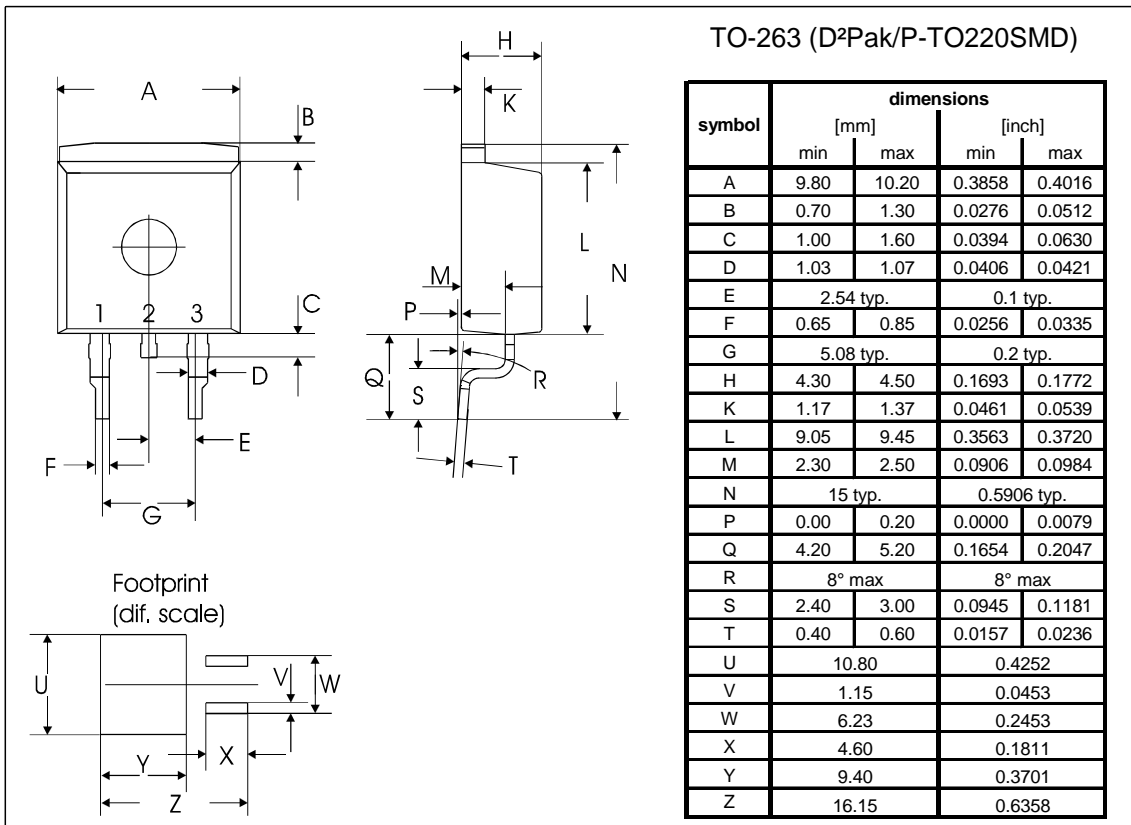
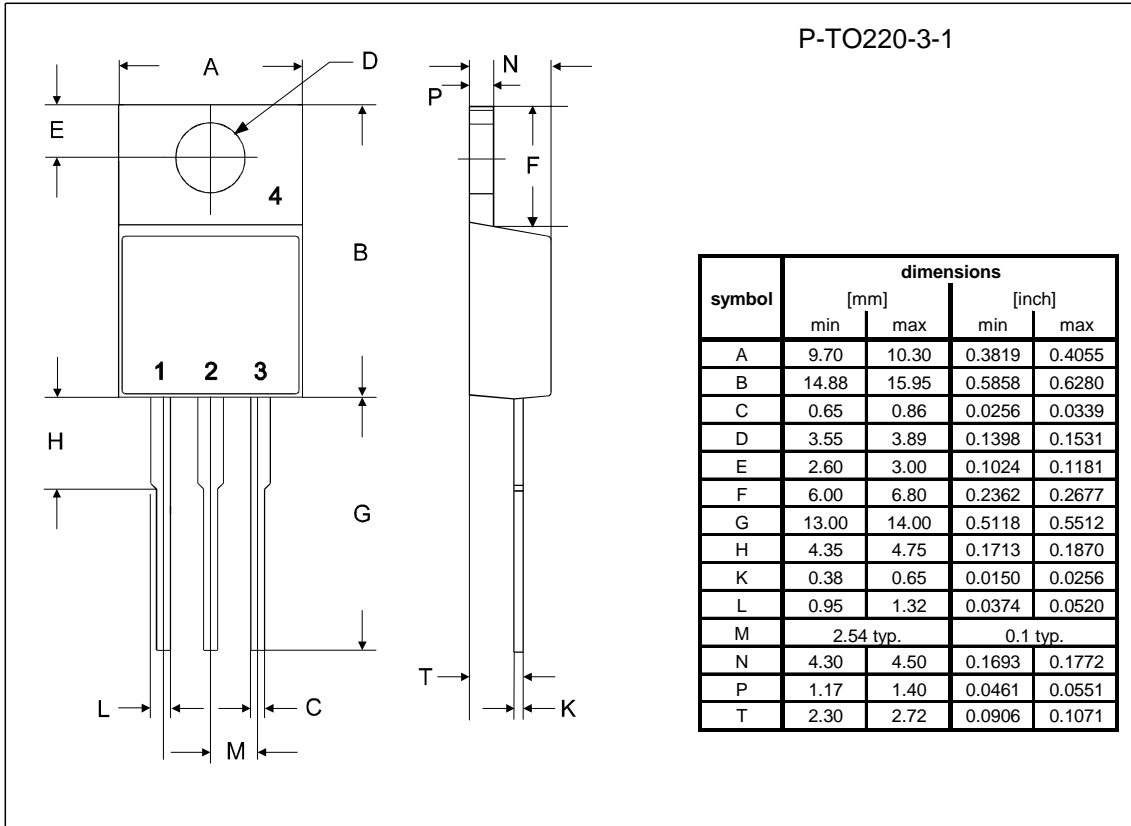
parameter: $V_{GS}=0\text{V}$, $f=1\text{ MHz}$

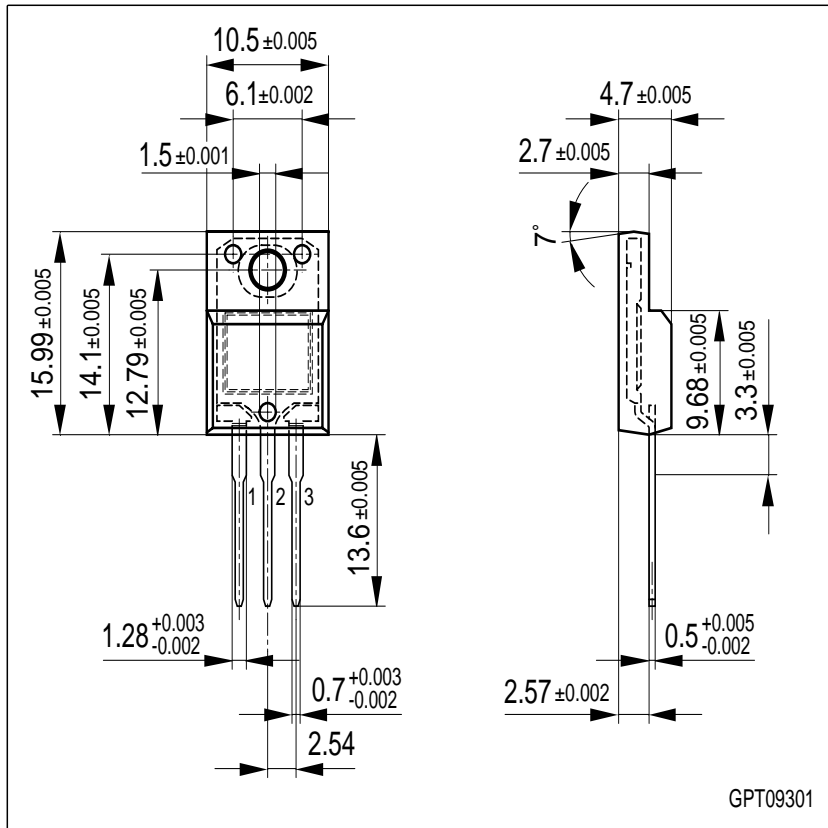


23 Typ. C_{OSS} stored energy

$$E_{OSS}=f(V_{DS})$$







Please refer to mounting instructions (application note AN-TO220-3-31-01)



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